

Form PTO 1449  
(Modified)U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICE

ATTY DOCKET NO.

6342-0039-2PCT

SERIAL NO.

09/446,888

## LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Toshiyuki FUTAKATA, et al.

FILING DATE

December 30, 1999

GROUP

2734

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<i>ph</i>	AA	6,167,037	12/26/2000	K. HIGUCHI, et al.			
<i>ph</i>	AB	5,673,260	09/30/97	N. UMEDA, et al.			
<i>ph</i>	AC	5,103,459	04/07/92	K. S. GILHOUSEN, et al.			
	AD						
	AE						
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	AL						
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	AN						

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## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
<i>Assuming not bl</i>	<i>ph</i>	AO 1180463	04/29/98	REPUBLIC OF CHINA (First page only with corr. WO 97/33400 and US 6,167,037)		X
	<i>ph</i>	AP WO 97/33400	09/12/97	WIPO (with English Abstract)		X
<i>Assuming not QRE bl</i>	<i>ph</i>	AQ 1124552	06/12/96	REPUBLIC OF CHINA (First page only with corr. WO 95/22213 and US 5,673,260)		X
	<i>ph</i>	AR WO 95/22213	08/17/95	WIPO (with English Abstract)		X
	<i>ph</i>	AS 5-130070	05/25/93	JAPAN (submitting English translation only)		
	<i>ph</i>	AT 10-56439	02/24/98	JAPAN (submitting English translation only)		
		AU				
		AV				

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

☐ Additional References sheet(s) attached

Examiner

*Pamela Khan*

Date Considered

12/2002

\*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. 6342-0039-2 PCT		SERIAL NO. 09/446,888	
LIST OF REFERENCES CITED BY APPLICANT (Use Several Sheets if Necessary)				APPLICANT Toshiyuki FUTAKATA, et al.			
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EXAMINER INITIAL	AA	DOCUMENT NUMBER	DATE	NAME	FILING DATE IF APPROPRIATE
	AA				
	AB				
	AC				
	AD				
	AE				
	AF				
	AG				

  

FOREIGN PATENT DOCUMENTS					
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO
	AH	<del>JP 06-504349 A</del>	<del>02/10/94</del>	<del>JAPAN</del> <i>not in English</i>	X
<i>Ph</i>	AI	JP 05-130070 A	05/25/93	JAPAN	X
<i>Ph</i>	AJ	JP 10-056439 A	02/24/98	JAPAN	X
	AK				
	AL				
	AM				
	AN				
	AO				

  

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)		
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	AS	
	AT	

  

EXAMINER <i>Pankaj Kumar</i>	DATE CONSIDERED <i>12/2002</i>
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